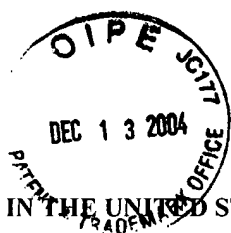


Docket No.: 50090-332



PATENT

AF/2829
ISW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Response Under 37 CFR 1.116 - Expedited Procedure

: Customer Number: 20277

Hisaya MORI, et al.

: Confirmation Number: 4507

Application No.: 09/927,368

: Group Art Unit: 2829

Filed: August 13, 2001

: Examiner: J. M. Hollington

For: APPARATUS AND METHOD FOR TESTING SEMICONDUCTOR INTEGRATED CIRCUIT

Mail Stop AF

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

Transmitted herewith is a Request for Reconsideration in the above-identified application.



No additional fee is required.



Applicant is entitled to small entity status under 37 CFR 1.27



Also attached: Terminal Disclaimer and Petition for Extension of Time

The fee has been calculated as shown below:

	NO. OF CLAIMS	HIGHEST PREVIOUSLY PAID FOR	EXTRA CLAIMS	RATE	FEE
Total Claims	11	20	0	\$50.00 =	\$0.00
Independent Claims	2	3	0	\$200.00 =	\$0.00
Multiple claims newly presented					\$0.00
Fee for extension of time					\$120.00
Terminal Disclaimer					\$130.00
Total of Above Calculations					\$250.00



Please charge my Deposit Account No. 500417 in the amount of \$250.00. An additional copy of this transmittal sheet is submitted herewith.



The Commissioner is hereby authorized to charge payment of any fees associated with this communication or credit any overpayment, to Deposit Account No. 500417, including any filing fees under 37 CFR 1.16 for presentation of extra claims and any patent application processing fees under 37 CFR 1.17.

Respectfully submitted,

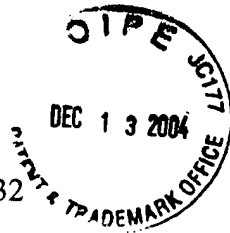
McDERMOTT WILL & EMERY LLP

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Washington, DC 20005-3096
Phone: 202.756.8000 SAB/AVY/dlb
Facsimile: 202.756.8087
Date: December 13, 2004

WDC99 1017471-1.050090.0332

**Please recognize our Customer No. 20277 as our
correspondence address.**



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BOX AF

PATENT

Docket No.: 50090-332

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Hisaya MORI, et al.

RESPONSE UNDER 37 CFR 1.116
EXPEDITED PROCEDURE

Application No.: 09/927,368

Filed: August 13, 2001

Customer No.: 20277
Confirmation No.: 4507

Group Art Unit: 2829

Examiner: J. M. Hollington

Title: APPARATUS AND METHOD FOR TESTING SEMICONDUCTOR INTEGRATED
CIRCUIT

REQUEST FOR RECONSIDERATION UNDER 37 CFR 1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This Request is submitted in response to the Office Action mailed August 12, 2004.